

<b>Notice of References Cited</b>	Application/Control No. 10/565,365		Applicant(s)/Patent Under Reexamination ONO ET AL.	
	Examiner Wyn' Q. HA		Art Unit 2854	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,145,834	11-2000	Hirota et al.	271/225
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 2002189319 A	07-2002	Japan	KUBO et al.	G03G15/00
*	O	JP 11005659 A	01-1999	Japan	HIROTA et al.	G03G 15/00
*	P	JP 10153889 A	06-1998	Japan	SUZUKI, KAORU	G03G 15/00
*	Q	JP 05155463 A	06-1993	Japan	NAGATANI, SHUZO	H04N 1/00
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.